

HA-2420, HA-2425

3.2 μ s Sample and Hold Amplifiers

The HA-2420 and HA-2425 is a monolithic circuit consisting of a high performance operational amplifier with its output in series with an ultra-low leakage analog switch and JFET input unity gain amplifier.

With an external hold capacitor connected to the switch output, a versatile, high performance sample-and-hold or track-and-hold circuit is formed. When the switch is closed, the device behaves as an operational amplifier, and any of the standard op amp feedback networks may be connected around the device to control gain, frequency response, etc. When the switch is opened the output will remain at its last level.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

November 1996

3.2μs Sample and Hold Amplifiers

Features

- **Maximum Acquisition Time**
 - 10V Step to 0.1%..... 4μs (Max)
 - 10V Step to 0.01%..... 6μs (Max)
- **Low Droop Rate (C_H = 1000pF)..... 5μV/ms (Typ)**
- **Gain Bandwidth Product 2.5MHz (Typ)**
- **Low Effective Aperture Delay Time 30ns (Typ)**
- **TTL Compatible Control Input**
- **±12V to ±15V Operation**

Applications

- **12-Bit Data Acquisition**
- **Digital to Analog Deglitcher**
- **Auto Zero Systems**
- **Peak Detector**
- **Gated Operational Amplifier**

Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
HA1-2420-2	-55 to 125	14 Ld CERDIP	F14.3
HA1-2425-5	0 to 75	14 Ld CERDIP	F14.3
HA3-2425-5	0 to 75	14 Ld PDIP	E14.3
HA4P2425-5	0 to 75	20 Ld PLCC	N20.35
HA9P2425-5	0 to 75	14 Ld SOIC	M14.15

Description

The HA-2420 and HA-2425 is a monolithic circuit consisting of a high performance operational amplifier with its output in series with an ultra-low leakage analog switch and JFET input unity gain amplifier.

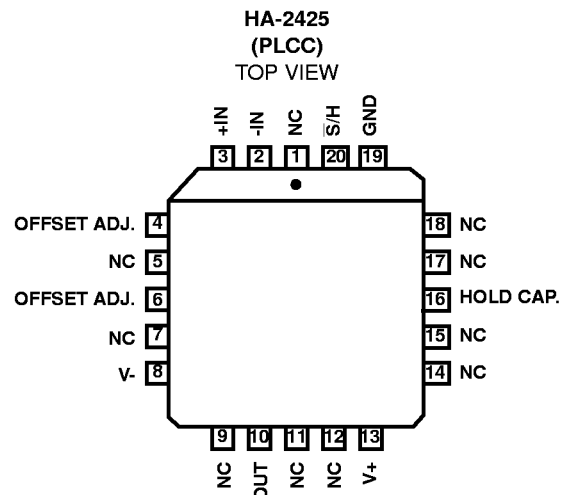
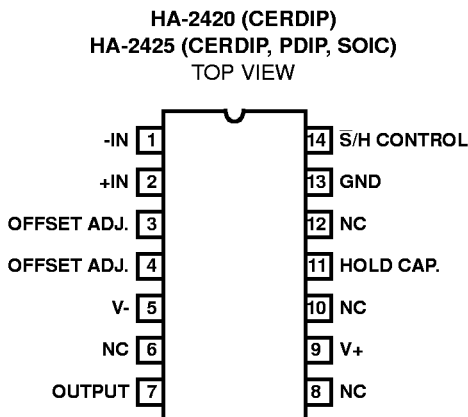
With an external hold capacitor connected to the switch output, a versatile, high performance sample-and-hold or track-and-hold circuit is formed. When the switch is closed, the device behaves as an operational amplifier, and any of the standard op amp feedback networks may be connected around the device to control gain, frequency response, etc. When the switch is opened the output will remain at its last level.

Performance as a sample-and-hold compares very favorably with other monolithic, hybrid, modular, and discrete circuits. Accuracy to better than 0.01% is achievable over the temperature range. Fast acquisition is coupled with superior droop characteristics, even at high temperatures. High slew rate, wide bandwidth, and low acquisition time produce excellent dynamic characteristics. The ability to operate at gains greater than 1 frequently eliminates the need for external scaling amplifiers.

The device may also be used as a versatile operational amplifier with a gated output for applications such as analog switches, peak holding circuits, etc. For more information, please see Application Note AN517.

The MIL-STD-883 data sheet for this device is available on request.

Pinouts



HA-2420, HA-2425

Absolute Maximum Ratings

Voltage Between V+ and V- Terminals	40V
Differential Input Voltage	24V
Digital Input Voltage (Sample and Hold Pin)	+8V, -15V
Output Current	Short Circuit Protected

Operating Conditions

Temperature Range	
HA-2420-2	-55°C to 125°C
HA-2425-5	0°C to 75°C
Supply Voltage Range (Typical)	±12V to ±15V

Thermal Information

Thermal Resistance (Typical, Note 1)	θ_{JA} (°C/W)	θ_{JC} (°C/W)
CERDIP Package	90	35
PDIP Package	100	N/A
PLCC Package	75	N/A
SOIC Package	120	N/A
Maximum Junction Temperature (Ceramic Packages)	175°C	
Maximum Junction Temperature (Plastic Package)	150°C	
Maximum Storage Temperature Range	-65°C to 150°C	
Maximum Lead Temperature (Soldering 10s)	300°C (PLCC and SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

- θ_{JA} is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications Test Conditions (Unless Otherwise Specified) $V_{SUPPLY} = \pm 15.0V$; $C_H = 1000pF$; Digital Input: $V_{IL} = +0.8V$ (Sample), $V_{IH} = +2.0V$ (Hold), Unity Gain Configuration (Output tied to Negative Input)

PARAMETER	TEST CONDITIONS	TEMP. (°C)	HA-2420-2			HA-2425-5			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
INPUT CHARACTERISTICS									
Input Voltage Range		Full	±10	-	-	±10	-	-	V
Offset Voltage		25	-	2	4	-	3	6	mV
		Full	-	3	6	-	4	8	mV
Bias Current		25	-	40	200	-	40	200	nA
		Full	-	-	400	-	-	400	nA
Offset Current		25	-	10	50	-	10	50	nA
		Full	-	-	100	-	-	100	nA
Input Resistance		25	5	10	-	5	10	-	MΩ
Common Mode Range		Full	±10	-	-	±10	-	-	V
TRANSFER CHARACTERISTICS									
Large Signal Voltage Gain	$R_L = 2k\Omega$, $V_O = 20V_{P-P}$	Full	25	50	-	25	50	-	kV/V
Common Mode Rejection	$V_{CM} = \pm 10V$	Full	80	90	-	74	90	-	dB
Hold Mode Feedthrough Attenuation (Note 2)	$f_{IN} \leq 100kHz$	Full	-	-76	-	-	-76	-	dB
Gain Bandwidth Product (Note 2)		25	-	2.5	-	-	2.5	-	MHz
OUTPUT CHARACTERISTICS									
Output Voltage Swing	$R_L = 2k\Omega$	Full	±10	-	-	±10	-	-	V
Output Current		25	±15	-	-	±15	-	-	mA
Full Power Bandwidth (Note 2)	$V_O = 20V_{P-P}$	25	-	100	-	-	100	-	kHz
Output Resistance	DC	25	-	0.15	-	-	0.15	-	Ω
TRANSIENT RESPONSE									
Rise Time (Note 2)	$V_O = 200mV_{P-P}$	25	-	75	100	-	75	100	ns
Overshoot (Note 2)	$V_O = 200mV_{P-P}$	25	-	25	40	-	25	40	%
Slew Rate (Note 2)	$V_O = 10V_{P-P}$	25	3.5	5	-	3.5	5	-	V/μs
DIGITAL INPUT CHARACTERISTICS									
Digital Input Current	$V_{IN} = 0V$	Full	-	-	-0.8	-	-	-0.8	mA
	$V_{IN} = 5V$	Full	-	-	20	-	-	20	μA
Digital Input Voltage	Low	Full	-	-	0.8	-	-	0.8	V
	High	Full	2.0	-	-	2.0	-	-	V
SAMPLE AND HOLD CHARACTERISTICS									
Acquisition Time (Note 2)	To 0.1% 10V Step	25	-	2.3	4	-	2.3	4	μs

HA-2420, HA-2425

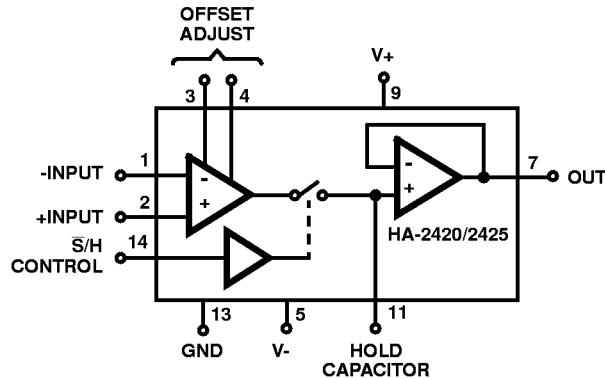
Electrical Specifications Test Conditions (Unless Otherwise Specified) $V_{SUPPLY} = \pm 15.0V$; $C_H = 1000pF$; Digital Input: $V_{IL} = +0.8V$ (Sample), $V_{IH} = +2.0V$ (Hold), Unity Gain Configuration (Output tied to Negative Input) **(Continued)**

PARAMETER	TEST CONDITIONS	TEMP. (°C)	HA-2420-2			HA-2425-5			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
Acquisition Time (Note 2)	To 0.01% 10V Step	25	-	3.2	6	-	3.2	6	μs
Hold Step Error	$V_{IN} = 0V$	25	-	10	20	-	10	20	mV
Hold Mode Settling Time	To $\pm 1mV$	25	-	860	-	-	860	-	ns
Aperture Time (Note 3)		25	-	30	-	-	30	-	ns
Effective Aperture Delay Time		25	-	30	-	-	30	-	ns
Aperture Uncertainty		25	-	5	-	-	5	-	ns
Drift Current (Note 2)	$V_{IN} = 0V$	25	-	5	-	-	5	-	μA
HA1-2420		Full	-	1.8	10	-	-	-	nA
HA1-2425		Full	-	-	-	-	0.1	1.0	nA
HA3-2425, HA4P2425, HA9P2425		Full	-	-	-	-	7.5	10.0	nA
POWER SUPPLY CHARACTERISTICS									
Supply Current (+)		25	-	3.5	5.5	-	3.5	5.5	mA
Supply Current (-)		25	-	2.5	3.5	-	2.5	3.5	mA
Power Supply Rejection		Full	80	90	-	74	90	-	dB

NOTES:

2. $A_v = \pm 1$, $R_L = 2k\Omega$, $C_L = 50pF$.
3. Derived from computer simulation only; not tested.

Functional Diagram



Test Circuits and Waveforms

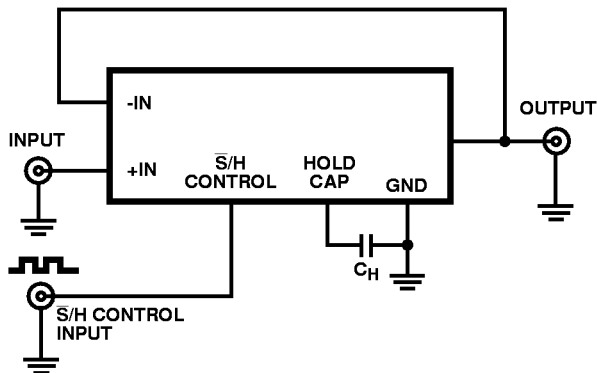
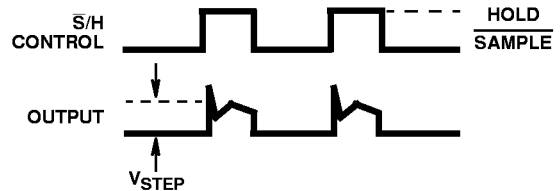


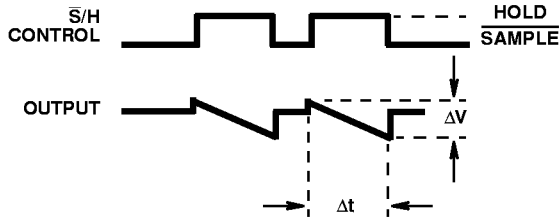
FIGURE 1. HOLD STEP ERROR AND DRIFT CURRENT



NOTE: Set rise/fall times of S/H Control to approximately 20ns.

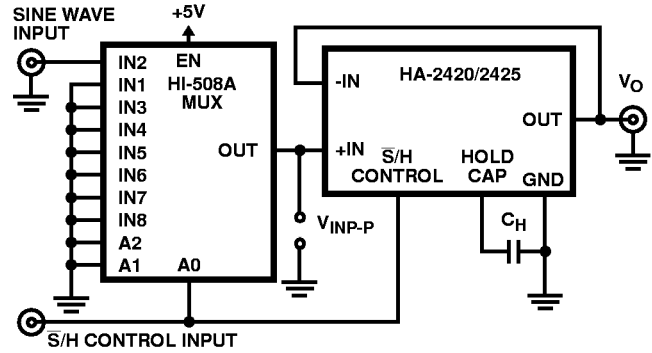
FIGURE 2. HOLD STEP ERROR TEST

Test Circuits and Waveforms (Continued)



NOTE: Measure the slope of the output during hold, $\Delta V/\Delta t$, and compute drift current from: $I_D = C_H \Delta V/\Delta t$.

FIGURE 3. DRIFT CURRENT TEST



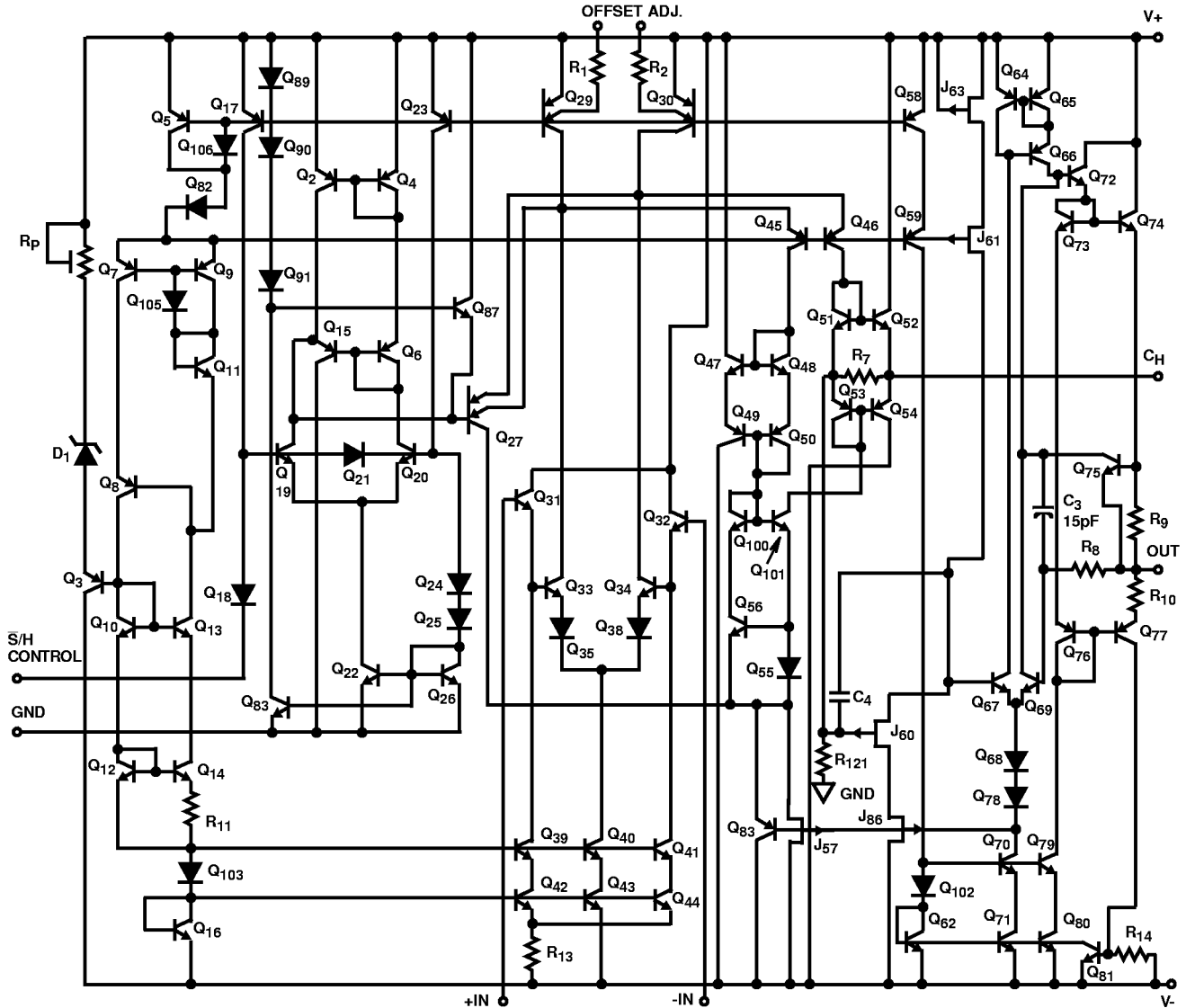
NOTE: Compute hold mode feedthrough attenuation from the formula:

$$\text{Feedthrough Attenuation} = 20 \log \frac{V_{\text{OUT HOLD}}}{V_{\text{IN HOLD}}}$$

Where $V_{\text{OUT HOLD}}$ = Peak-to-Peak value of output sinewave during the hold mode.

FIGURE 4. HOLD MODE FEEDTHROUGH ATTENUATION

Schematic Diagram



Application Information

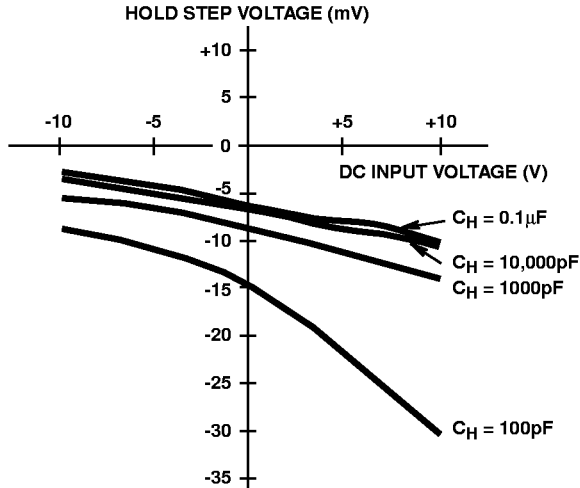


FIGURE 5. HOLD STEP vs INPUT VOLTAGE

Offset Adjustment

The offset voltage of the HA-2420 and HA-2425 may be adjusted using a 100kΩ trim pot, as shown in Figure 8. The recommended adjustment procedure is:

Apply 0V to the sample-and-hold input, and a square wave to the \bar{S}/H control.

Adjust the trim pot for 0V output in the hold mode.

Gain Adjustment

The linear variation in pedestal voltage with sample-and-hold input voltage causes a -0.06% gain error ($C_H = 1000pF$). In some applications (D/A deglitcher, A/D converter) the gain error can be adjusted elsewhere in the system, while in other applications it must be adjusted at the sample-and-hold. The two circuits shown below demonstrate how to adjust gain error at the sample-and-hold.

The recommended procedure for adjusting gain error is:

1. Perform offset adjustment.
2. Apply the nominal input voltage that should produce a +10V output.
3. Adjust the trim pot for +10V output in the hold mode.
4. Apply the nominal input voltage that should produce a -10V output.
5. Measure the output hold voltage ($V_{-10NOMINAL}$). Adjust the trim pot for an output hold voltage of

$$\frac{(V_{-10NOMINAL}) + (-10V)}{2}$$

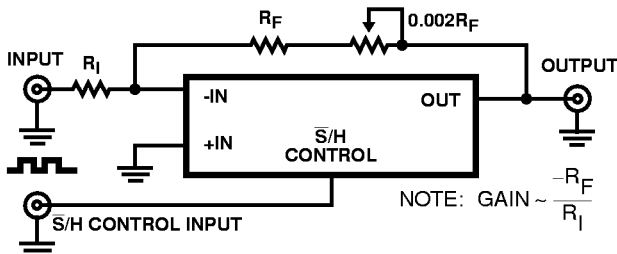


FIGURE 6. INVERTING CONFIGURATION

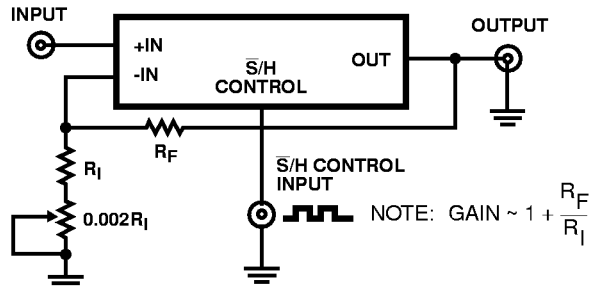


FIGURE 7. NON-INVERTING CONFIGURATION

Figure 8 shows a typical unity gain circuit, with Offset Zeroing. All of the other normal op amp feedback configurations may be used with the HA-2420/2425. The input amplifier may be used as a gated amplifier by utilizing Pin 11 as the output. This amplifier has excellent drive capabilities along with exceptionally low switch leakage.

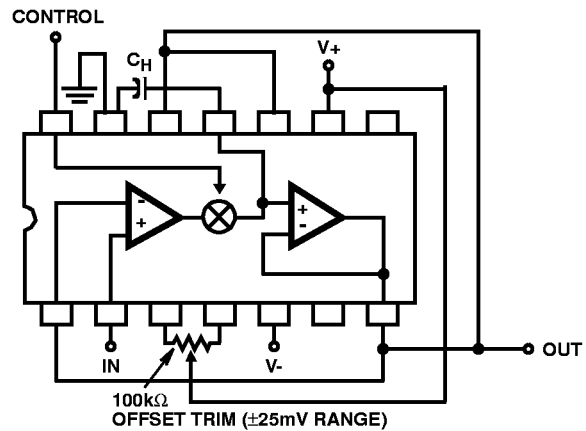


FIGURE 8. BASIC SAMPLE-AND-HOLD (TOP VIEW)

The method used to reduce leakage paths on the PC board and the device package is shown in Figure 9. This guard ring is recommended to minimize the drift during hold mode.

The hold capacitor should have extremely high insulation resistance and low dielectric absorption. Polystyrene (below 85°C), Teflon, or Parlene types are recommended.

For more applications, consult Harris Application Note AN517, or the factory applications group.

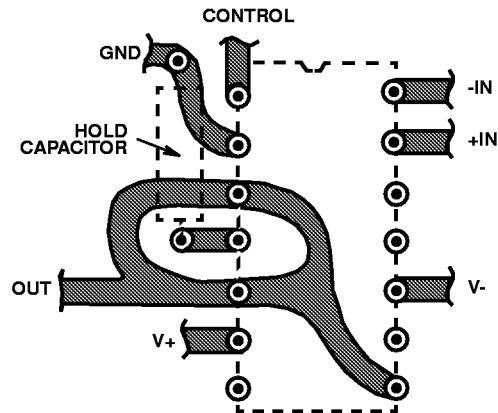


FIGURE 9. GUARD RING LAYOUT (BOTTOM VIEW)

Glossary of Terms

Acquisition Time

The time required following a "sample" command, for the output to reach its final value within $\pm 0.1\%$ or $\pm 0.01\%$. This is the minimum sample time required to obtain a given accuracy, and includes switch delay time, slewing time and settling time.

Aperture Time

The time required for the sample-and-hold switch to open, independent of delays through the switch driver and input amplifier circuitry. The switch opening time is that interval between the conditions of 10% open and 90% open.

Effective Aperture Delay Time (EADT)

The difference between the digital delay time from the Hold command to the opening of the S/H switch, and the propagation time from the analog input to the switch.

EADT may be positive, negative or zero. If zero, the S/H amplifier will output a voltage equal to V_{IN} at the instant the Hold command was received. For negative EADT, the output in Hold (exclusive of pedestal and droop errors) will correspond to a value of V_{IN} that occurred before the Hold command.

Aperture Uncertainty

The range of variation in Effective Aperture Delay Time. Aperture Uncertainty (also called Aperture Delay Uncertainty, Aperture Time Jitter, etc.) sets a limit on the accuracy with which a waveform can be reconstructed from sample data.

Drift Current

The net leakage current from the hold capacitor during the hold mode. Drift current can be calculated from the droop rate using the formula:

$$I_D \text{ (pA)} = C_H \text{ (pF)} \times \frac{\Delta V}{\Delta t} \text{ (V/s)}$$

Typical Performance Curves

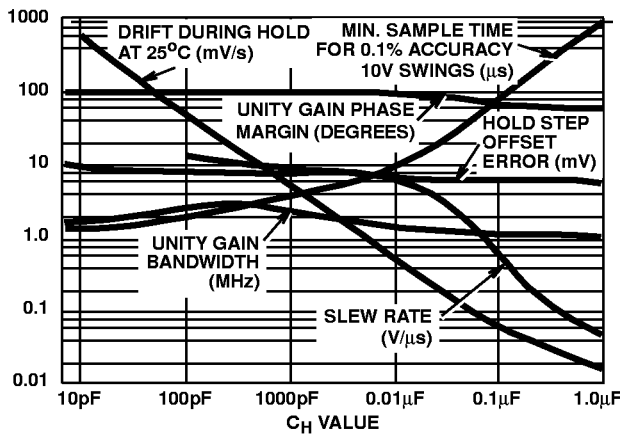


FIGURE 10. TYPICAL SAMPLE AND HOLD PERFORMANCE AS A FUNCTION OF HOLDING CAPACITOR

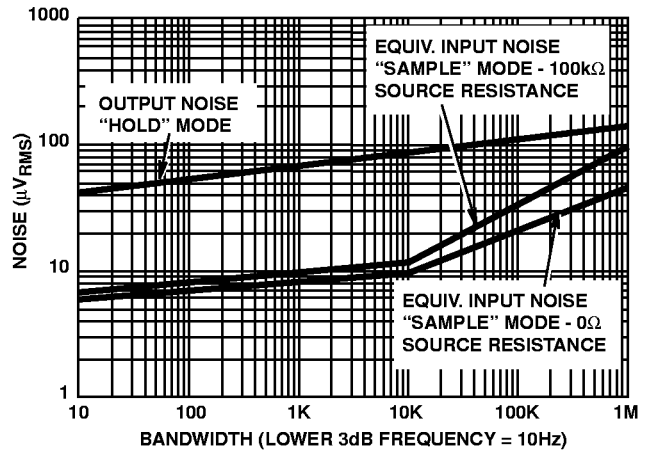


FIGURE 11. BROADBAND NOISE CHARACTERISTICS

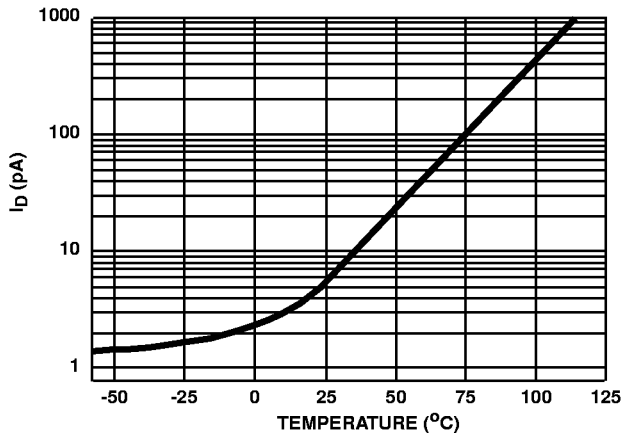


FIGURE 12. DRIFT CURRENT vs TEMPERATURE

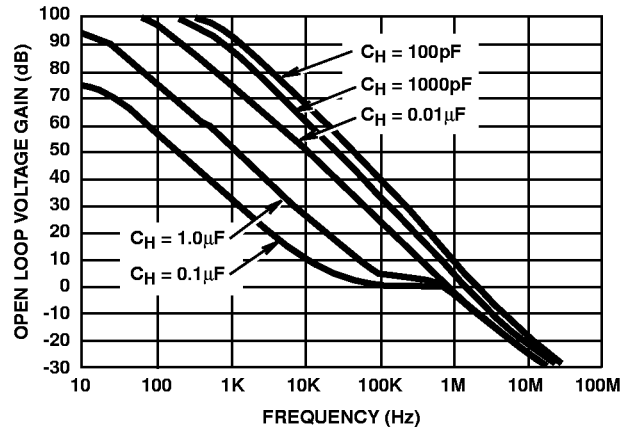


FIGURE 13. OPEN LOOP FREQUENCY RESPONSE

Typical Performance Curves (Continued)

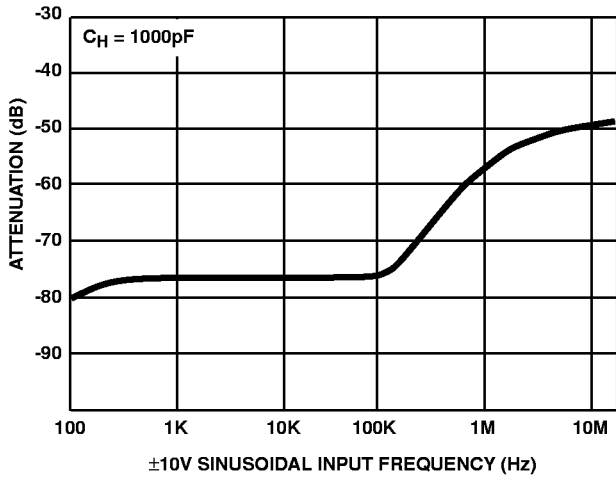


FIGURE 14. HOLD MODE FEED THROUGH ATTENUATION

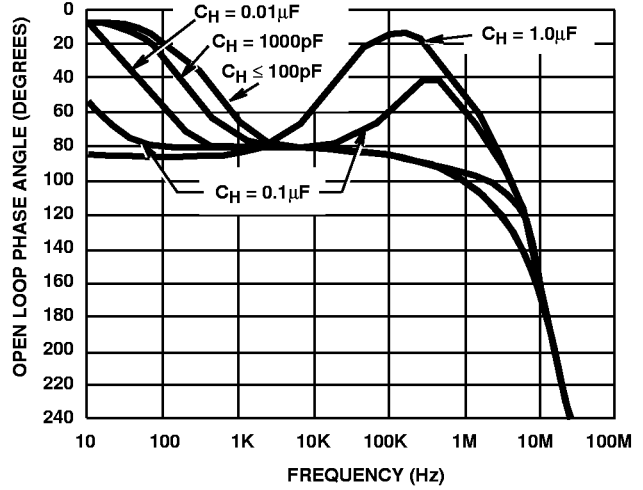


FIGURE 15. OPEN LOOP PHASE RESPONSE

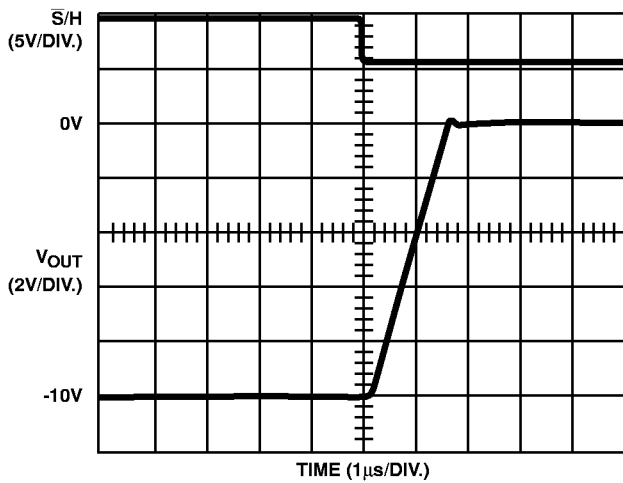


FIGURE 16. ACQUISITION TIME ($C_H = 1000\text{pF}$)

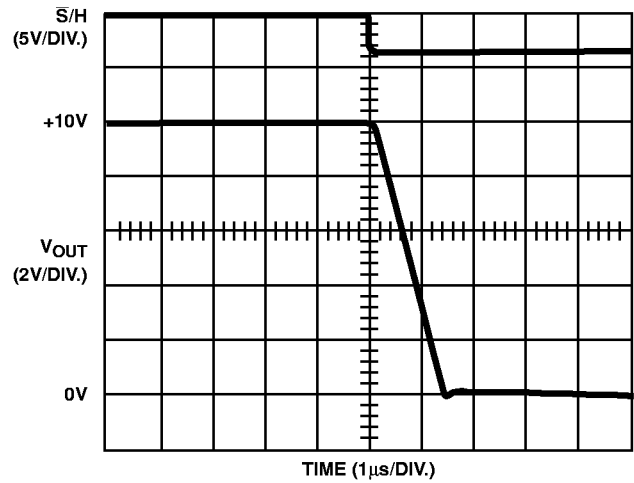


FIGURE 17. ACQUISITION TIME ($C_H = 1000\text{pF}$)

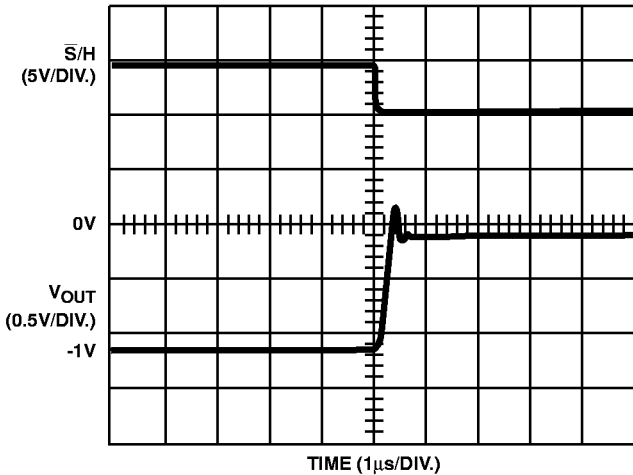


FIGURE 18. ACQUISITION TIME ($C_H = 1000\text{pF}$)

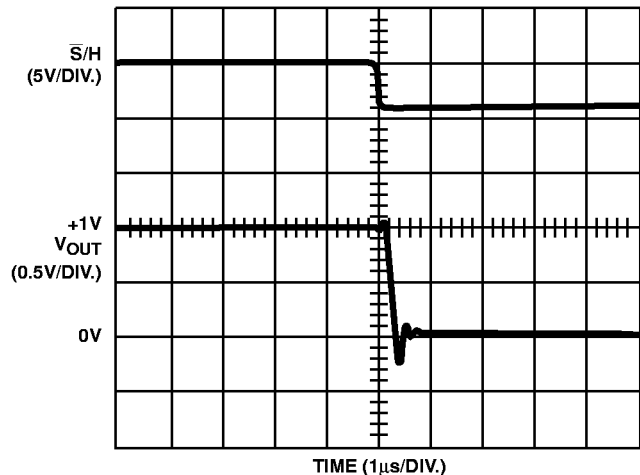


FIGURE 19. ACQUISITION TIME ($C_H = 1000\text{pF}$)

Typical Performance Curves (Continued)

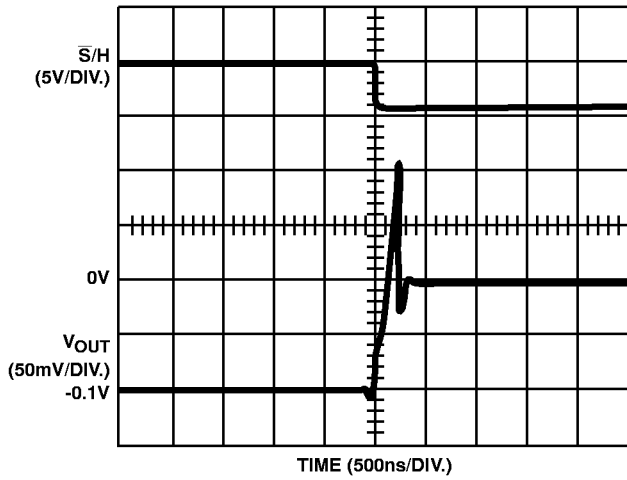


FIGURE 20. ACQUISITION TIME ($C_H = 1000\text{pF}$)

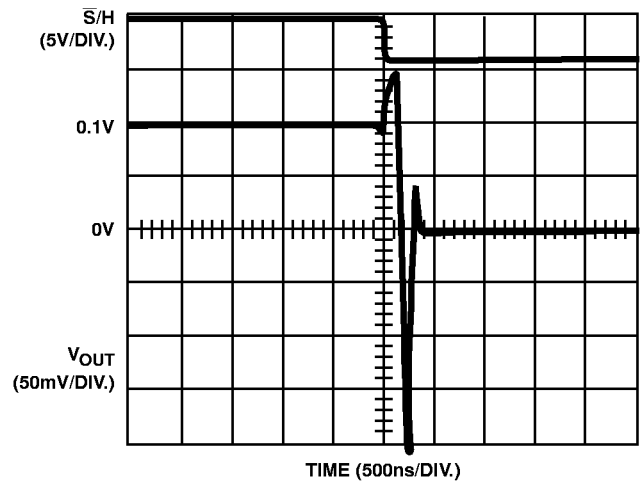


FIGURE 21. ACQUISITION TIME ($C_H = 1000\text{pF}$)

HA-2420, HA-2425

Die Characteristics

DIE DIMENSIONS:

102 mils x 61 mils x 19 mils
2590 μ m x 1550 μ m x 483 μ m

METALLIZATION:

Type: Al, 1% Cu
Thickness: 16k \AA \pm 2k \AA

SUBSTRATE POTENTIAL:

V-

BACKSIDE FINISH:

Gold, Nickel, Silicon, etc.

PASSIVATION:

Type: Nitride (Si_3N_4) over Silox (SiO_2 , 5% Phos.)
Silox Thickness: 12k \AA \pm 2k \AA
Nitride Thickness: 3.5k \AA \pm 1.5k \AA

TRANSISTOR COUNT:

78

PROCESS:

Bipolar Dielectric Isolation

Metallization Mask Layout

HA-2420, HA-2425

